

Search Notes

Application/Control No.

09/693,790

Examiner

Annan Q. Shang

Applicant(s)/Patent under
Reexamination

JERDING ET AL

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
725	37-61	12/21/2005	A.S

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR